Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10087699	CHENG ET AL.
Examiner	Art Unit
David M Naff	1657

SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES			
Search Notes	Date	Examiner	
West-see search history	5/22/08	DMN	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

U.S. Patent and Trademark Office Part of Paper No.: 20080516